

TEST REPORT

Applicant Name : M5Stack Technology Co., Ltd
Address : Block A10, Expo Bay South Coast, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China
Report Number : 2604P13970E-RF
FCC ID: 2AN3WSTAMPLORA1262

Test Standard (s)

47 CFR §2.1091

Sample Description

Product Type: M5Stamp LoRa-1262
Model No.: Stamp LoRa-1262 IF, Stamp LoRa-1262, Stamp LoRa-1262 I
Trade Mark: 
M5STACK

Date Received: 2026-01-19
Report Date: 2026-03-05

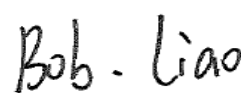
Test Result:	The EUT complied with the standards above.
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Prepared and Checked By:



Jason Fan
EMC Engineer

Approved By:



Bob.Liao
EMC Engineer

Note: This report must not be used by the customer to claim product certification, approval, or endorsement by A2LA, or any agency of the Federal Government. The information marked "#" is provided by the applicant, the laboratory is not responsible for its authenticity and this information can affect the validity of the result in the test report. Customer model name, addresses, names, trademarks etc. are included but no need marked.
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DOCUMENT REVISION HISTORY

Revision Number	Report Number	Description of Revision	Date of Revision
Rev.00	2604P13970E-RF	Original Report	2026-03-05

GENERAL INFORMATION

Product Description for Equipment under Test (EUT)

Product	M5Stamp LoRa-1262
Tested Model	Stamp LoRa-1262 IF
Multiple Model	Stamp LoRa-1262, Stamp LoRa-1262 I
Model Difference [#]	Stamp LoRa-1262 IF: With IPEX socket, with 12P FPC socket. Stamp LoRa-1262 I: With IPEX socket, without 12P FPC socket. Stamp LoRa-1262: Neither of them is equipped. Please refer to DOS letter for details. The applicant provided model "Stamp LoRa-1262 IF" for testing.
Frequency Range	903.0-914.9MHz
Maximum Conducted Output Power	LoRa: 9.95dBm
Antenna Specification [#]	3.08 dBi (It is provided by the manufacturer.)
Voltage Range [#]	DC 3.3V from Auxiliary device
Sample Serial Number	3GC4-1 (Assigned by ATC, Shenzhen)
Sample/EUT Status	Good condition

Objective

This test report is in accordance with Part 2-Subpart J, Part 15-Subparts C and Part 2-Subpart J, Radiofrequency Radiation Exposure of the Federal Communication Commission rules.

The tests were performed in order to determine compliance with FCC §2.1091 rules.

Test Facility

The test site used by Shenzhen Accurate Technology Co., Ltd. to collect test data is located on the Floor 1, KuMaKe Building, Dongzhou Community, Guangming Street, Guangming District, Shenzhen, Guangdong, China.

Accredited by American Association for Laboratory Accreditation (A2LA).The Certificate Number is 4297.01.

RF EXPOSURE

Applicable Standard

According to subpart 2.1091 systems operating under the provisions of this section shall be operated in a manner that ensures the public is not exposed to RF energy level in excess of the communication guidelines.

Limits for General Population/Uncontrolled Exposure

Limits for General Population/Uncontrolled Exposure				
Frequency Range (MHz)	Electric Field Strength (V/m)	Magnetic Field Strength (A/m)	Power Density (mW/cm ²)	Averaging Time (Minutes)
0.3-1.34	614	1.63	*(100)	30
1.34-30	824/f	2.19/f	*(180/f ²)	30
30-300	27.5	0.073	0.2	30
300-1500	/	/	f/1500	30
1500-100,000	/	/	1.0	30

f = frequency in MHz

* = Plane-wave equivalent power density

Result

Calculated Formulary:

Predication of MPE limit at a given distance

$$S = \frac{PG}{4\pi R^2}$$

S = power density (in appropriate units, e.g. mW/cm²)

P = power input to the antenna (in appropriate units, e.g., mW).

G = power gain of the antenna in the direction of interest relative to an isotropic radiator, the power gain factor, is normally numeric gain.

R = distance to the center of radiation of the antenna (appropriate units, e.g., cm)

Mode	Frequency (MHz)	Antenna Gain [#]		Tune up conducted power [#]		Evaluation Distance (cm)	Power Density (mW/cm ²)	MPE Limit (mW/cm ²)
		(dBi)	(numeric)	(dBm)	(mW)			
LoRa	903.0-914.9	3.08	2.03	10	10	20	0.004	0.602

Note 1: The tune-up power and antenna gain are declared by the applicant.

To maintain compliance with the FCC's RF exposure guidelines, place the equipment at least 20cm from nearby persons.

Result: Compliance

EXHIBIT A-EUT PHOTOGRAPHS

Please refer to the Attachment No.1 2604P13970E-RF EUT External Photos and Attachment No.2 2604P13970E-RF EUT Internal Photos

******* END OF REPORT *******